


<b>Search Notes</b>  	<b>Application/Control No.</b>  10586561	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  Benny Lee	<b>Art Unit</b>  2817

SEARCHED			
Class	Subclass	Date	Examiner
333	239, 241, 242, 21R	4 January 2010	BTL
343	786	6 January 2010	BTL
29	600	7 January 2010	BTL

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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